Docket No.: 96790.P197d3 Express Mail #EV339906522US

#### IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Fumihiko Kobayashi et al.

Divisional of Serial No.: 10/067,553

For:

OPTICAL SEMICONDUCTOR DEVICE AND METHOD OF FABRICATING THE SAME

### INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents P.O. Box 1450 Arlington, VA 22313-1450

Dear Sir:

In accordance with 37 CFR 1.56, Applicant hereby discloses the prior art references that have been submitted and/or cited in the following related applications/patents:

Serial No.	Filing Date	Patent No.	Issue Date
10/067,553	February 4, 2002		
09/027,012	February 18, 1998	6,430,986	June 11, 2002
08/534,333	September 27, 1995	5,783,844	July 21, 1998

Forms PTO-1449 (modified), PTO-1449 and PTO0892 are enclosed herewith. Copies of the references are not provided as permitted by 37 CFR 1.98(d).

Respectfully submitted,

BLAKELY, SOKOLOFF, TAYLÒR & ZAFMAN

Date: / 0

By:

Eric S. Hyman Reg. No. 30,139

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